

# Update on Statistical Uncertainty of $D^0 \rightarrow \pi^+ K^-$ SSA

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# Prescription for SSA (and uncertainty) Calculation

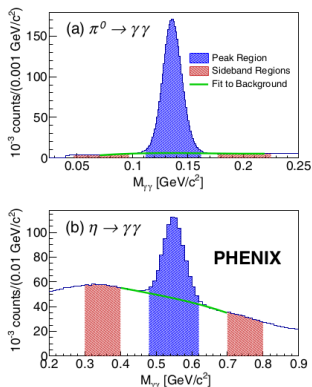


Figure 1: Illustrative plot from PHENIX :  $\pi^0$  (above) and  $\eta$  (below) from di-photon invariant mass spectra

- Following the standard practice at STAR, PHENIX and COMPASS:
- From invariant mass spectra in azimuthal ( $\phi$ ) slices, define signal region (often  $2\sigma$  around the peak), count total, calculate raw asymmetry (and uncertainty)
- Far from signal peak, count pure background, calculate background asymmetry (and uncertainty)
- Correct 'raw' asymmetry with background asymmetry (and relative contribution) to extract 'signal' asymmetry (and uncertainty)

## Now Some Explicit Equations

Transverse Single Spin Asymmetry :

$$A_N(\phi) = \frac{1}{P \langle |\cos(\phi)| \rangle} \frac{N(\phi) - \mathcal{R}.N(\phi + \pi)}{N(\phi) + \mathcal{R}.N(\phi + \pi)}$$

where  $P$  is beam polarization,  $\langle |\cos(\phi)| \rangle = \frac{\int_{\phi_1}^{\phi_2} \cos(\phi) d\phi}{\phi_2 - \phi_1}$  is the average of the cosine of azimuth in the  $\phi$  bin,  $\mathcal{R}$  is relative luminosity for opp. pol. dir. of beam,  $N$ 's are counts in  $\phi$  bins. One can use  $N(\phi) = N_L$  and  $N(\phi + \pi) = N_R$  for left and right as simplified notation

Statistical Uncertainty of SSA (propagation of error assuming two independent variables  $N(\phi)$  and  $N(\phi + \pi)$ ) :

$$\sigma_{A_N}(\phi) = \frac{1}{P \langle |\cos(\phi)| \rangle} \frac{2\mathcal{R}.N(\phi).N(\phi + \pi)}{(N(\phi) + \mathcal{R}N(\phi + \pi))^2} \sqrt{\left(\frac{\sigma_{N(\phi)}}{N(\phi)}\right)^2 + \left(\frac{\sigma_{N(\phi+\pi)}}{N(\phi + \pi)}\right)^2}$$

# Simplifications

Assume  $\mathcal{R} \sim 1$ ,  $N(\phi) \sim N(\phi + \pi) = N$  where  $N$  is the count of candidates in a  $\phi$  bin ( $N = N_{\text{detected}}/n$  if you have  $n$  bins in azimuth) and assume Poisson distribution of counts (so that  $\sigma_N = \sqrt{N}$ )

Simplified version of statistical uncertainty of SSA :

$$\sigma_{A_N}(\phi) = \frac{1}{P\langle |\cos(\phi)| \rangle} \frac{1}{\sqrt{2N}}$$

## Finally : The Signal

Corrected signal SSA :

$$A_N^{Sig}(\phi) = \frac{A_N^{Raw}(\phi) - r \cdot A_N^{Bkg}(\phi)}{1 - r}$$

where  $r = \frac{N_{Bkg}}{N_{raw}}$  is background contribution to raw/total count under the signal peak

Corrected signal statistical uncertainty of SSA :

$$\sigma_{A_N^{Sig}}(\phi) = \frac{\sqrt{\sigma_{A_N^{Raw}}^2(\phi) + r^2 \sigma_{A_N^{Bkg}}^2(\phi)}}{1 - r}$$

# Procedure

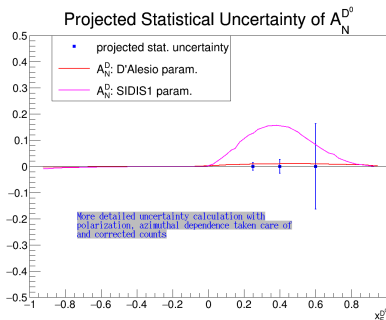
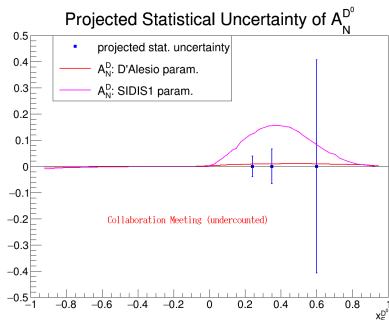
- After background suppression cuts, scale MC counts of signals in  $x_F$  bins to get counts in 1 year of data
- Using S/B ratio from analysis (1:8), estimate raw/total and background counts ( $N_t = 9N_s$  and  $N_b = 8N_s$  respectively) - **done because we lack enough bkg MC to get bkg count directly**
- For each  $x_F$  bin, distribute  $N_t$  and  $N_b$  in 12  $\phi$  bins, estimate raw and background uncertainties in each  $\phi$  bin
- For each pair of  $(\phi, \phi + \pi)$  bins, extract corrected signal uncertainty  $\sigma_{A_N}(\phi)$
- For  $x_F$  bin, combine uncertainties for independent measurements in 6 (pairs of left-right)  $\phi$  bins

$$\sigma_{A_N}(x_F) = \frac{1}{\sqrt{\sum_{i=1}^6 \frac{1}{\sigma_{A_N}^2(\phi_i)}}}$$

# Calculations

- From 'ideal case' simulation : 4 Million open-charm events  $\Rightarrow$  2 Million  $D^0 \rightarrow \pi^+ K^-$  (forced decay)
- From cross-sections and 1 year integrated luminosity : 240 Million  $D^0 \rightarrow \pi^+ K^-$  produced
- A factor of 120 gain over counts from MC - I applied BR again by mistake in last calculation - underestimated signal
- MC analysis signal counts in  $x_F$  bins : 2416 ( $0.2 \leq x_F \leq 0.3$ ), 841 ( $0.3 \leq x_F \leq 0.5$ ), 22 ( $x_F > 0.5$ )
- Use 12 equal azimuthal( $\phi$ ) bins and polarization  $P = 0.7$
- Statistical Uncertainties in  $x_F$  bins : 0.0156, 0.0265, 0.1640

# Projected Asymmetry of $A_N^{D^0}$



Statistical uncertainties are for  $D^0$  counts ONLY, whereas calculations are for INCLUSIVE  $D/\bar{D}$ . So, in a proper comparison, uncertainties will be even shorter (by including  $\bar{D}^0, D^+, D^-$ ).

We get very precise measurement here, but remember this is the 'ideal case' and assumes full statistics of produced counts. Reality will be somewhat different.



# Outlook

- A big 'thank you' to Igor Denisenko - long discussions with him lead to more careful and more detailed calculation
- Igor will probably demonstrate a parallel method of estimating statistical uncertainty in next physics meeting - following the method of least squares in the pdg statistics chapter - calculating the covariance matrix for a linear combination of two independent functions
- Currently looking at  $D^+ \rightarrow \pi^+ \pi^+ K^-$  reconstruction
- Also looking at a multivariate analysis for the ideal  $D^0$  case with Dimitrije Maletic to see if that can help